

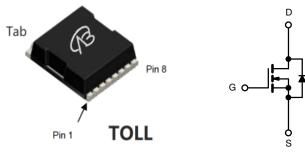
N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A)	Q _g (TYP.)			
80	0.001at V _{GS} = 10 V	350	80 nC			

FEATURES

- SGT technology Power MOSFET
- Maximum 150 °C junction temperature
- \bullet 100 % R_g and UIS tested





Top View N-Channel MOSFET

APPLICATIONS

- Power supplies:
 - Uninterruptible power supplies
 - AC/DC switch-mode power supplies
 - Lighting
- Synchronous rectification
- DC/DC converter
- Motor drive switch
- DC/AC inverter
- Solar micro inverter
- Class D audio amplifier

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V _{DS}	80	V			
Gate-Source Voltage		V _{GS}		± 20		
Ocalia de Paris Ocasal (T., 450.00)	T _C = 25 °C		350			
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	- I _D	210			
Pulsed Drain Current (t = 100 μs)	I _{DM}	1050	Α			
Avalanche Current	L = 0.5 mH	I _{AS}	70			
Single Avalanche Energy ^a	L = 0.5 IIII	E _{AS}	1400	mJ		
Marine a Berna Biorination 3	T _C = 25 °C	В	370 ^b	10/		
Maximum Power Dissipation ^a	T _C = 100 °C	T _C = 100 °C		W		
Operating Junction and Storage Temperature	Range	T _J , T _{stg}	-55 to +150	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	LIMIT	UNIT			
Junction-to-Ambient (PCB Mount) ^c	R _{thJA}	40	°C/W			
Junction-to-Case (Drain)	R _{thJC}	0.4	J C/VV			

Notes

- a. Duty cycle \leq 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80	-	-	V	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	-	4.5	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 250	nA	
		V _{DS} = 64 V, V _{GS} = 0 V	-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 64 V, V _{GS} = 0 V, T _J = 125 °C	-	-	150	μA	
		V _{DS} = 64 V, V _{GS} = 0 V, T _J = 150°C	-	-	5	mA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	90	-	-	Α	
Dunin Course On Otata Basistana 2	Б	V _{GS} = 10 V, I _D = 50 A	-	0.0010	-	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D =30 A	-	0.0075	-		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A	-	75	-	S	
Dynamic ^b			•				
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 100 V, f = 1 MHz	-	15000	-	pF	
Output Capacitance	C _{oss}		-	246	-		
Reverse Transfer Capacitance	C _{rss}		-	21	-		
Total Gate Charge ^c	Qg	V _{DS} = 100 V, V _{GS} = 10 V, I _D = 60 A	-	80	96	nC	
Gate-Source Charge ^c	Q_{gs}		-	16.7	-		
Gate-Drain Charge ^c	Q _{gd}		-	16.9	-		
Gate Resistance	R_g	f = 1 MHz	1.5	3	5	Ω	
Turn-On Delay Time ^c	t _{d(on)}		-	15	29		
Rise Time ^c	t _r	$V_{DD} = 100 \text{ V}, R_L = 1.66 \Omega$	-	20	25	ns ns	
Turn-Off Delay Time °	t _{d(off)}	$I_D \cong 60 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	31	71		
Fall Time ^c	t _f		-	20	35		
Drain-Source Body Diode Ratings ar	nd Characteri	stics ^b (T _C = 25 °C)	•				
Pulsed Current (t = 100 μs)	I _{SM}		-	-	1050	Α	
Forward Voltage ^a	V _{SD}	I _F = 10 A, V _{GS} = 0 V	-	0.8	1.2	٧	
Reverse Recovery Time	t _{rr}		-	180	-	ns	
Peak Reverse Recovery Charge	I _{RM(REC)}	$I_F = 30 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$	-	11	20	Α	
Reverse Recovery Charge	Q _{rr}		-	0.9	1.8	μC	

Notes

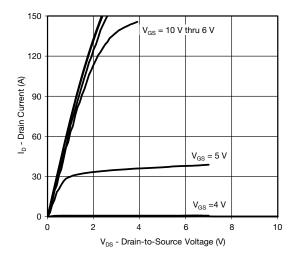
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- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing. c. Independent of operating temperature.

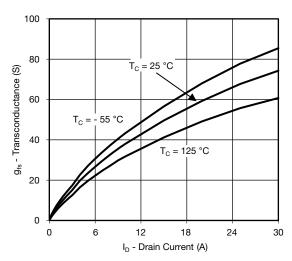
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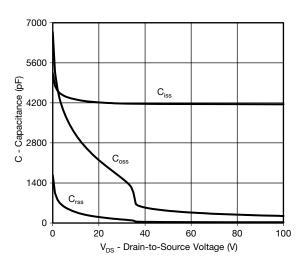
TYPICAL CHARACTERISTICS ($T_A = 25 \, ^{\circ}\text{C}$, unless otherwise noted)



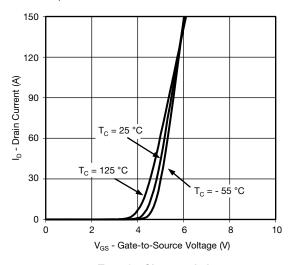




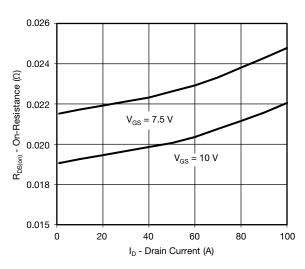
Transconductance



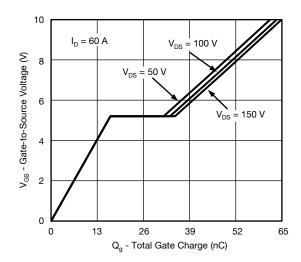
Capacitance



Transfer Characteristics



On-Resistance vs. Drain Current

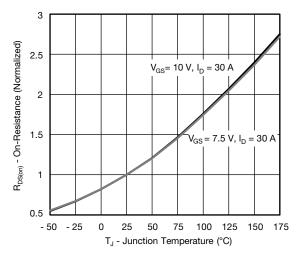


Gate Charge

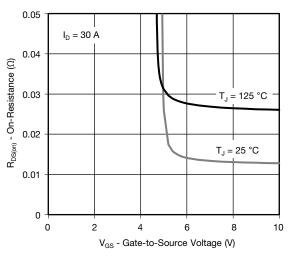
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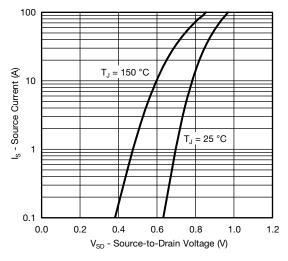
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



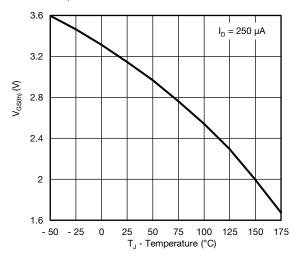
On-Resistance vs. Junction Temperature



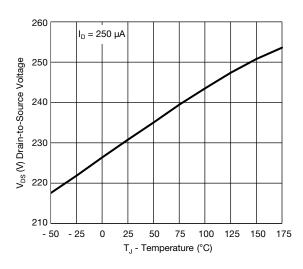
On-Resistance vs. Gate-to-Source Voltage



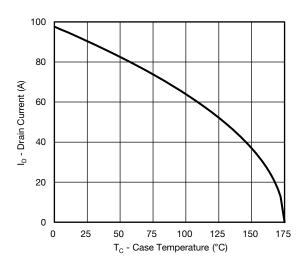
Source Drain Diode Forward Voltage



Threshold Voltage



Drain Source Breakdown vs. Junction Temperature

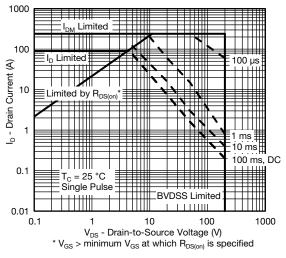


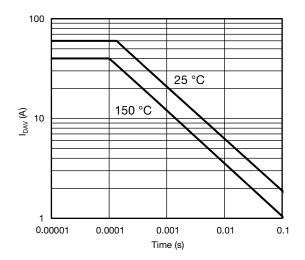
Current De-rating

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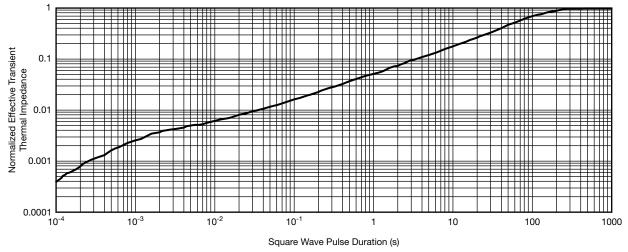
THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)





Safe Operating Area

Single Pulse Avalanche Current Capability vs. Time

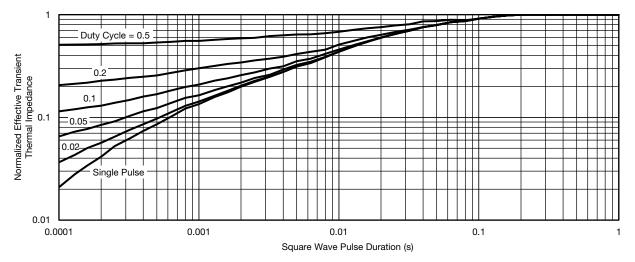


Normalized Thermal Transient Impedance, Junction-to-Ambient

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THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

Note

- The characteristics shown in the two graphs Normalized Transient Thermal Impedance Junction to Ambient (25 $^{\circ}\text{C})$

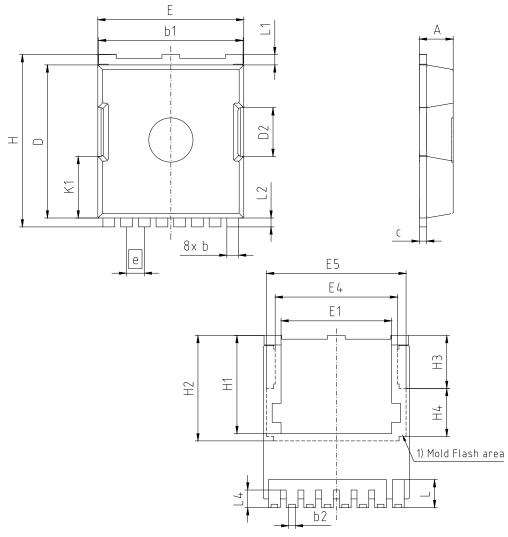
can widely vary depending on actual application parameters and operating conditions.

- Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities

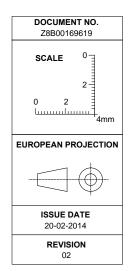
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Package Outlines



DIM	MILLIMETERS		INCHES		
DIN	MIN	MAX	MIN	MAX	
Α	2.20	2.40	0.087	0.094	
b	0.70	0.90	0.028	0.035	
b1	9.70	9.90	0.382	0.390	
b2	0.42	0.50	0.017	0.020	
С	0.40	0.60	0.016	0.024	
D	10.28	10.58	0.405	0.416	
D2	3.	3.30		130	
E	9.70	10.10	0.382	0.398	
E1	7.50		0.295		
E4	8.	8.50 0.335		35	
E5	9.	46	0.372		
е	1.20	1.20 (BSC)		0.047 (BSC)	
Н	11.48	11.88	0.452	0.468	
H1	6.55	6.75	0.258	0.266	
H2	7.15		0.281		
H3	3.59		0.141		
H4	3.26		0.128		
N	8		8		
K1	4.18		0.165		
L	1.60	2.10	0.063	0.083	
L1	0.	0.70 0.028)28	
L2	0.	.60 0.024)24	
L4	1.00	1.30	0.039	0.051	





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